

SKM600GB07E3



SEMITRANS® 3

Trench IGBT Modules

SKM600GB07E3

Target Data

Features

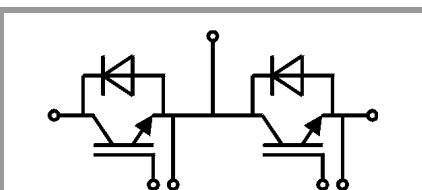
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability, self limiting to $6 \times I_{Cnom}$
- Fast & soft inverse CAL diodes
- Insulated copper baseplate using DBC Technology (Direct Copper Bonding)
- With integrated gate resistor

Typical Applications*

- AC inverter drives
- UPS

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max.
- Recommended $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for $T_j = 150^\circ\text{C}$
- Use of soft R_G necessary



GB

Absolute Maximum Ratings			
Symbol	Conditions	Values	Unit
IGBT			
V_{CES}	$T_j = 25^\circ\text{C}$	650	V
I_C	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	758
		$T_c = 80^\circ\text{C}$	571
I_{Cnom}		600	A
I_{CRM}	$I_{CRM} = 3 \times I_{Cnom}$	1800	A
V_{GES}		-20 ... 20	V
t_{psc}	$V_{CC} = 360\text{ V}$ $V_{GE} \leq 15\text{ V}$ $V_{CES} \leq 650\text{ V}$	$T_j = 150^\circ\text{C}$	6
			μs
T_j		-40 ... 175	$^\circ\text{C}$
Inverse diode			
V_{RRM}	$T_j = 25^\circ\text{C}$	650	V
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	770
		$T_c = 80^\circ\text{C}$	562
I_{Fnom}		600	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	1200	A
I_{FSM}	$t_p = 10\text{ ms}$, $\sin 180^\circ$, $T_j = 25^\circ\text{C}$	4320	A
T_j		-40 ... 175	$^\circ\text{C}$
Module			
$I_{t(RMS)}$		500	A
T_{stg}	module without TIM	-40 ... 125	$^\circ\text{C}$
V_{isol}	AC sinus 50 Hz, $t = 1\text{ min}$	4000	V

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 600\text{ A}$ $V_{GE} = 15\text{ V}$ chipllevel	$T_j = 25^\circ\text{C}$	1.45	1.90	V
		$T_j = 150^\circ\text{C}$	1.70	2.10	V
V_{CE0}	chipllevel	$T_j = 25^\circ\text{C}$	0.90	1.00	V
		$T_j = 150^\circ\text{C}$	0.82	0.90	V
r_{CE}	$V_{GE} = 15\text{ V}$ chipllevel	$T_j = 25^\circ\text{C}$	0.92	1.50	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	1.47	2.00	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 9.6\text{ mA}$	5.1	5.8	6.4	V
I_{CES}	$V_{GE} = 0\text{ V}$, $V_{CE} = 650\text{ V}$, $T_j = 25^\circ\text{C}$			0.5	mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	37.0		nF
C_{oes}		$f = 1\text{ MHz}$	2.32		nF
C_{res}		$f = 1\text{ MHz}$	1.10		nF
Q_G	$V_{GE} = -8\text{ V} \dots +15\text{ V}$		4800		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		0.5		Ω
$t_{d(on)}$	$V_{CC} = 300\text{ V}$	$T_j = 150^\circ\text{C}$	215		ns
t_r	$I_C = 600\text{ A}$ $V_{GE} = +15/-15\text{ V}$	$T_j = 150^\circ\text{C}$	78		ns
		$T_j = 150^\circ\text{C}$	4.7		mJ
E_{on}		$T_j = 150^\circ\text{C}$	1110		ns
$t_{d(off)}$		$T_j = 150^\circ\text{C}$	100		ns
t_f	$di/dt_{on} = 7620\text{ A}/\mu\text{s}$ $di/dt_{off} = 660\text{ A}/\mu\text{s}$ $du/dt = 1330\text{ V}/\mu\text{s}$	$T_j = 150^\circ\text{C}$	37		mJ
E_{off}		$T_j = 150^\circ\text{C}$			mJ
$R_{th(j-c)}$	per IGBT			0.08	K/W
$R_{th(c-s)}$	per IGBT ($\lambda_{grease} = 0.81\text{ W}/(\text{m}^2\text{K})$)		0.033		K/W
$R_{th(c-s)}$	per IGBT, pre-applied phase change material		0.021		K/W



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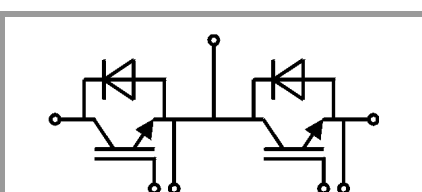
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
$V_F = V_{EC}$	$I_F = 600 \text{ A}$ $V_{GE} = 0 \text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$		1.40	1.76	V
		$T_j = 150^\circ\text{C}$		1.39	1.77	V
V_{F0}	chipelevel	$T_j = 25^\circ\text{C}$		1.04	1.24	V
		$T_j = 150^\circ\text{C}$		0.85	0.99	V
r_F	chipelevel	$T_j = 25^\circ\text{C}$		0.60	0.88	m Ω
		$T_j = 150^\circ\text{C}$		0.89	1.31	m Ω
I_{RRM}	$I_F = 600 \text{ A}$	$T_j = 150^\circ\text{C}$		390		A
Q_{rr}	$di/dt_{off} = 4940 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		54		μC
E_{rr}	$V_{GE} = \pm 15 \text{ V}$ $V_{CC} = 300 \text{ V}$	$T_j = 150^\circ\text{C}$		9.3		mJ
$R_{th(j-c)}$	per diode				0.104	K/W
$R_{th(c-s)}$	per diode ($\lambda_{grease} = 0.81 \text{ W}/(\text{m}^2\text{K})$)			0.038		K/W
$R_{th(c-s)}$	per diode, pre-applied phase change material			0.028		K/W
Module						
L_{CE}				15		nH
R_{CC+EE}	measured per switch	$T_c = 25^\circ\text{C}$		0.55		m Ω
		$T_c = 125^\circ\text{C}$		0.85		m Ω
$R_{th(c-s)1}$	calculated without thermal coupling			0.009		K/W
$R_{th(c-s)2}$	including thermal coupling, T_s underneath module ($\lambda_{grease} = 0.81 \text{ W}/(\text{m}^2\text{K})$)			0.014		K/W
$R_{th(c-s)2}$	including thermal coupling, T_s underneath module, pre-applied phase change material			0.01		K/W
M_s	to heat sink M6		3		5	Nm
M_t		to terminals M6	2.5		5	Nm
						Nm
w					325	g



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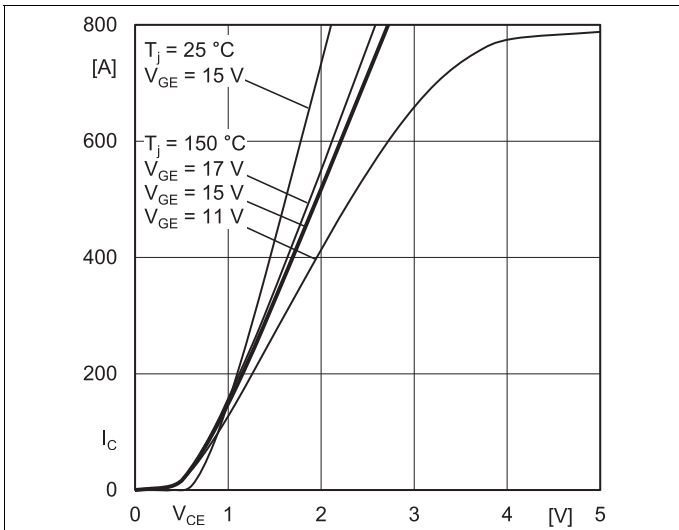


Fig. 1: Typ. output characteristic, inclusive $R_{CC'+EE'}$

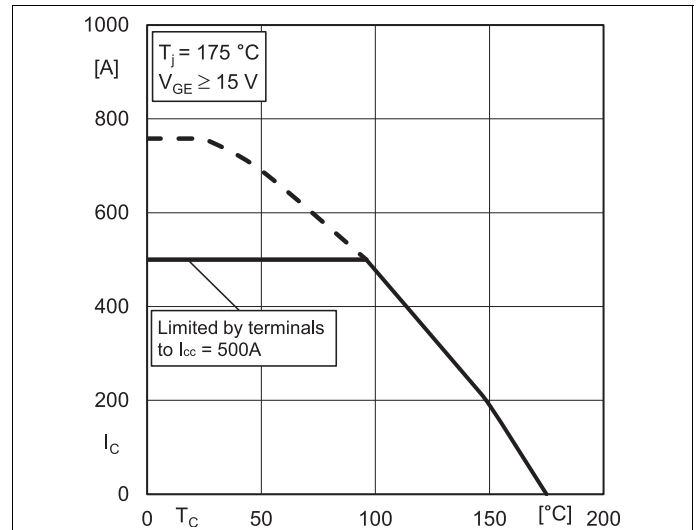


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

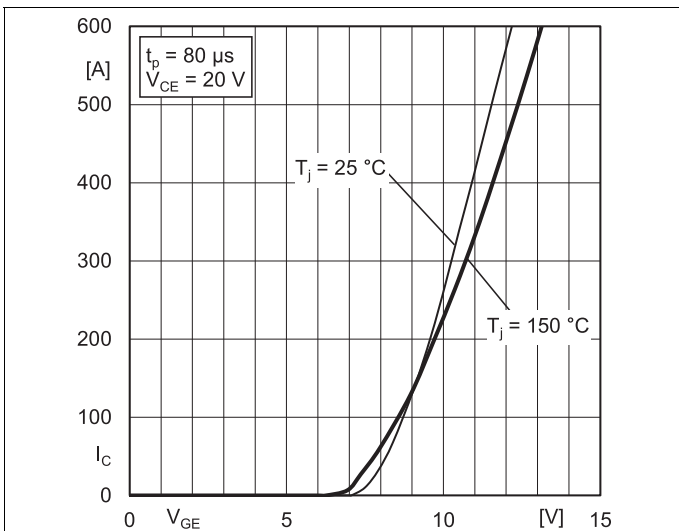


Fig. 5: Typ. transfer characteristic

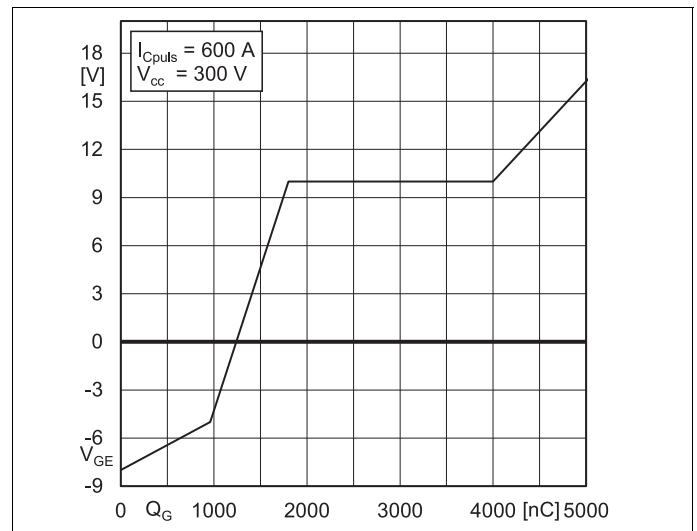


Fig. 6: Typ. gate charge characteristic

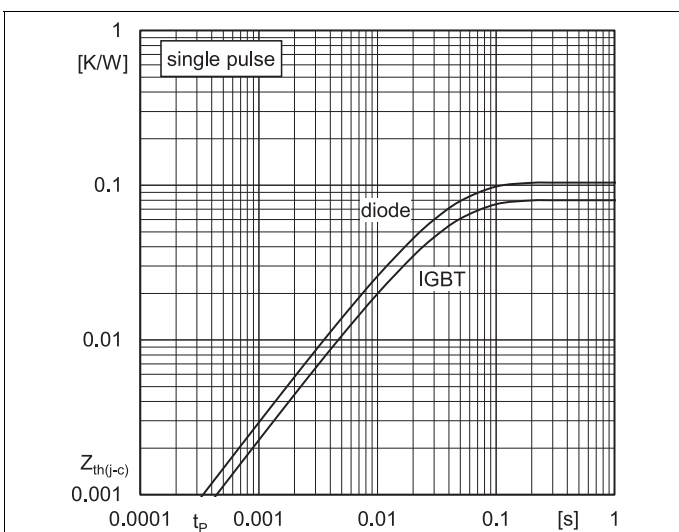


Fig. 9: Transient thermal impedance

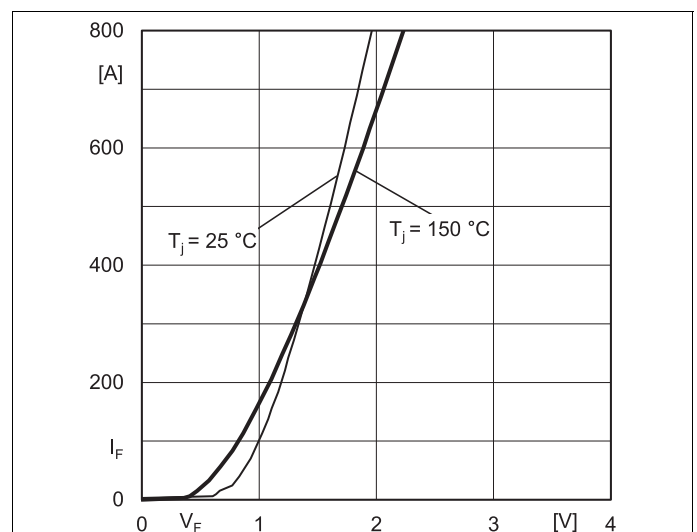


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'+EE'}$

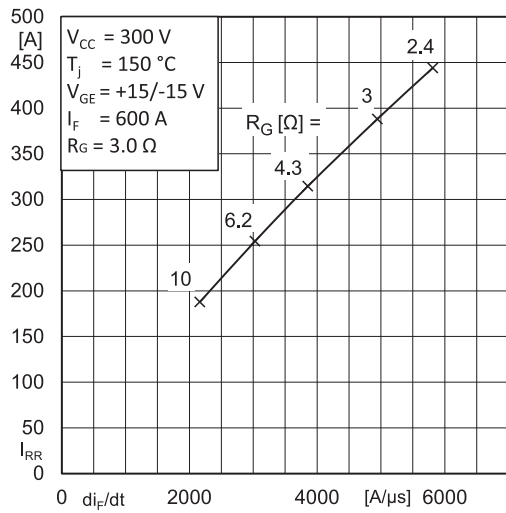


Fig. 11: CAL diode peak reverse recovery current

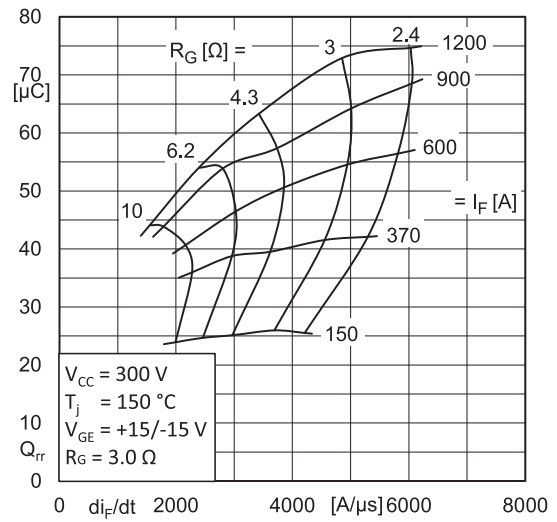
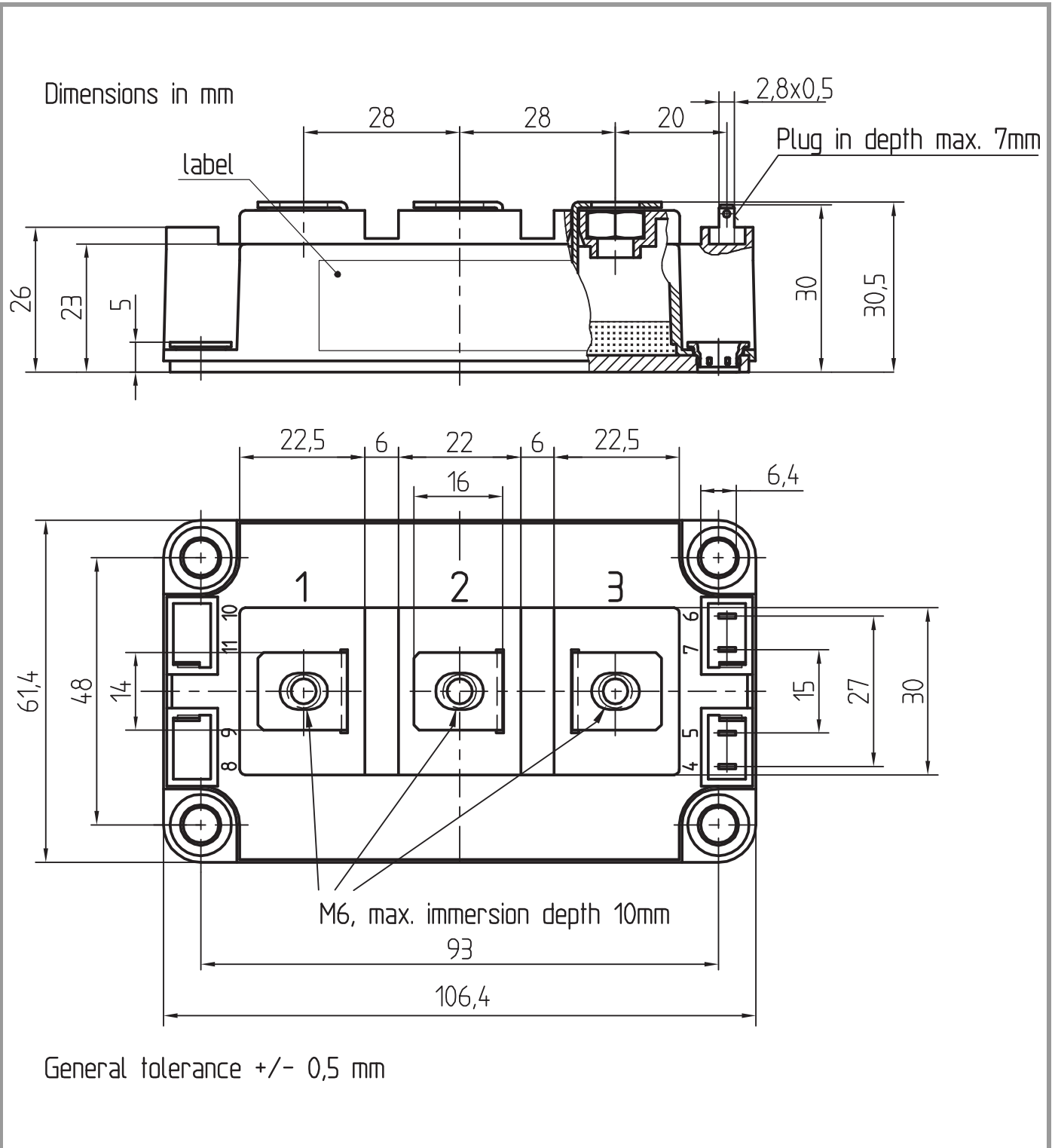
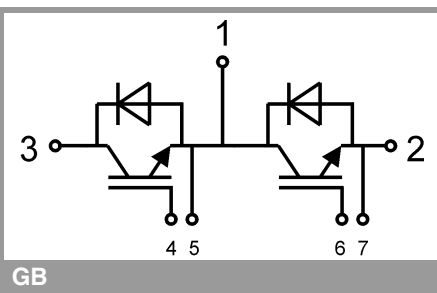


Fig. 12: Typ. CAL diode peak reverse recovery charge

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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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